



**MICROCHIP**

**QUALIFICATION REPORT SUMMARY  
RELIABILITY LABORATORY**

**PCN #: DSNO-19JBXI931**

**Date:  
May 19, 2024**

**Qualification of MTAI as an additional assembly site for selected  
ATSAMC20E1x, ATSAMC21E1x, ATSAMD20E1x, ATSAMD21E1x,  
ATSAMD21E15x, ATSAMDA1E1x, ATSAML10E1x, ATSAML11E1x,  
PIC32CM1216JH0xx, PIC32CM1216LExx, PIC32CM1216LSxx,  
PIC32CM1216MCxx, PIC32CM1602GVxx, PIC32CM3204GVxx,  
PIC32CM3204JHxx, PIC32CM6408JHxx, PIC32CM6408MCxx device  
families available in 32L VQFN (5x5x1mm) wettable flank package.  
This will qualify by similarity (QBS).**



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## Package Qualification Report

**Purpose:** Qualification of MTAI as an additional assembly site for selected ATSAMC20E1x, ATSAMC21E1x, ATSAMD20E1x, ATSAMD21E1x, ATSAMD21E15x, ATSAMDA1E1x, ATSAML10E1x, ATSAML11E1x, PIC32CM1216JH0xx, PIC32CM1216LExx, PIC32CM1216LSxx, PIC32CM1216MCxx, PIC32CM1602GVxx, PIC32CM3204GVxx, PIC32CM3204JHxx, PIC32CM6408JHxx, PIC32CM6408MCxx device families available in 32L VQFN (5x5x1mm) wettable flank package. This will qualify by similarity (QBS).

**CCB No.:** 4601 (Qual Date: May 07, 2024) and 7972.001

<b><u>Misc.</u></b>	Assembly site	MTAI
	BD Number	BDE006697-01
	MP Code (MPC)	66P0145LXYXY
	Part Number (CPN)	PIC32CM5164JH01064-E/5LX
	MSL information	MSL1
	Assembly Shipping Media (T/R, Tube/Tray)	T/R - TUBE - TRAY
	Base Quantity Multiple (BQM)	3300 - 40 - 260
	Reliability Site	MPHIL
<b><u>Lead-Frame</u></b>	Paddle size	264x264
	Material	C194
	DAP Surface Prep	Cu
	Treatment	BOT on Paddle
	Process	Etched
	Lead-lock	No
	Part Number	10106409
	Lead Plating	Matte Tin
	Strip Size	250x70mm
	Strip Density	120
<b><u>Bond Wire</u></b>	Material	CuPdAu
<b><u>Die Attach</u></b>	Part Number	3280
	Conductive	Yes
<b><u>MC</u></b>	Part Number	G700LTD
<b><u>PKG</u></b>	Package Type	VQFN
	Pin/Ball Count	64
	PKG width/size	9 x 9 mm



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## Package Qualification Report

### Manufacturing Information

Assembly Lot No.
MTAI242201781.000
MTAI242202179.000
MTAI242202518.000

### Result

Pass

Fail

66P01 in VQFN 64 9x9 WF (5LX) package, Standard 125°C using CuPdAu/2N wire, MSL1 assembled in MTAI pass reliability test per QCI-39000 which was conducted at MPHL rel lab. This package is qualified Moisture/Reflow Sensitivity Classification Level 1 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard.

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard / Method	Qty. (Acc.)	Def/SS	Result	Remarks	
<b>Precondition Prior Perform Reliability Tests (At MSL Level 1)</b>	<b>Electrical Test :25°C</b> M1_SV_1024	JESD22- A113,  JIP/ IPC/JEDE C J-STD- 020E	231 per lot	Lot 1 0/231	Pass	Good Devices	
				Lot 2 0/231	Pass		
				Lot 3 0/231	Pass		
	<b>Bake</b> 150°C, 24 hrs System: HERAEUS		231 per lot				
	<b>Moisture Soak</b> 168h(85°C/85%RH) System: VOTSCH VC4034		231 per lot				
	<b>Reflow</b> 3x Convection-Reflow 265°C max System: Mancorp CR.5000F		231 per lot	Lot 1 0/231	Pass		
				Lot 2 0/231	Pass		
				Lot 3 0/231	Pass		
	<b>Electrical Test :</b> 25°C M1_SV_1024		231 per lot	Lot 1 0/231	Pass		
				Lot 2 0/231	Pass		
				Lot 3 0/231	Pass		

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>High Temperature Storage Life</b>	<b>Stress Condition:</b> Bake 175°C, 500 hrs System: HERAEUS  <b>Electrical Test:</b> 25°C /130°C System: M1_SV_1024	JESD22-A103	45 units 1 lot	Lot 1 0/45	Pass	
<b>HAST</b>	<b>Stress Condition:</b> (Standard) 110°C, 85%RH, 264 hrs. VOLTS=5.5V System: HIRAYAMA HASTEST PC-422R8  <b>Electrical Test:</b> 25°C /130°C System: M1_SV_1024	JESD22-A110	77 units per lot	Lot 1 0/77  Lot 2 0/77  Lot 3 0/77	Pass  Pass  Pass	Parts had been pre-conditioned at 260°C
<b>UNBIASED HAST</b>	<b>Stress Condition:</b> (Standard) + 110°C, 85%RH, 264 hrs. System: HIRAYAMA HASTEST PC-422R8  <b>Electrical Test:</b> 25°C System: M1_SV_1024	JESD22-A118	77 units per lot	Lot 1 0/77  Lot 2 0/77  Lot 3 0/77	Pass  Pass  Pass	Parts had been pre-conditioned at 260°C

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard / Method	Qty. (Acc.)	Def/SS	Result	Remarks
<b>Temp Cycle</b>	<b>Stress Condition:</b> (Standard) - 65°C/150°C, 500 Cycles System : Votsch VTS <sup>2</sup> 7012  <b>Electrical Test:</b> 25°C/130°C System: M1_SV_1024	JESD22-A104	77 units per lot	Lot 1 0/77  Lot 2 0/77  Lot 3 0/77	Pass  Pass  Pass	Parts had been pre-conditioned at 260°C
	<b>Wire Bond Pull WBP</b>	Mil. Std. 883-2011	5 units, 30 bonds 1 lot	Lot 1 0/30	Pass	
<b>Wire Bond Pull WBP , 0 Hour</b>		Mil. Std. 883-2011	5 units, 30 bonds 1 lot	Lot 1 0/30	Pass	
<b>Wire Bond Shear WBS, 0Hour</b>		CDF-AEC-Q100-001	5 units, 30 bonds 1 lot	Lot 1 0/30	Pass	
<b>Standard Pb-free Solderability</b>	>95% lead coveragef	J-STD-002E	22 units 1 lot	0/22	Pass	